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LIST OF ABBREVIATIONS

BN	- Bayesian Network
CMM	- Capability Maturity Model
CMMI	- Capability Maturity Model Integration
COE	- Centre of Excellence
COQUALMO	- Constructive Quality Model
CUT	- Code and Unit Testing
DfSS	- Design for Six Sigma
DMADV	- Design, Measure, Analyze, Design, Verify
FMEA	- Failure Mode and Effect Analysis
FP	- Function Point
IPF	- In-Process Fault
ISP	- Internet Service Provider
JARING	- Joint Advanced Research Integrated Networking
KJ	- Kawakita Jiro
KLOC	- Kilo Lines of Code
LOC	- Lines of Code
MEMS	- Micro-Electro-Mechanical Systems
MIMOS	- Malaysian Institute for Microelectronic Systems
MOF	- Ministry of Finance
MSA	- Measurement System Analysis
NEMS	- Nano-Electro-Mechanical Systems
PC	- Personal Computer
PDF	- Probability Density Function

QFD	- Quality Function Deployment
R&D	- Research and Development
SDLC	- Software Development Life Cycle
SEI	- Software Engineering Institute
TER	- Test Effectiveness Ratio
UAT	- User Acceptance Test
V&V	- Verification and Validation